

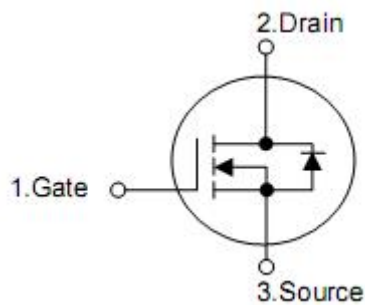
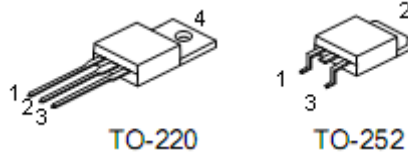
1. Features

- n $R_{DS(on)}=10.5m\Omega @ V_{GS}=10V$
- n Lead free and green device available
- n Low Rds-on to minimize conductive loss
- n High avalanche current

2. Applications

- n Power supply
- n UPS
- n Battery management system

3.Symbol



Pin	Function
1	Gate
2	Drain
3	Source
4	Drain

4. Absolute maximum ratings

($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter		Symbol	Rating	Units
Drain-source voltage		V_{DSS}	60	V
Gate-source voltage		V_{GSS}	± 25	V
Continuous drain current	$T_C=25^\circ\text{C}$	I_D^3	50	A
	$T_C=100^\circ\text{C}$		35	A
Pulse drain current	$T_C=25^\circ\text{C}$	I_{DP}^4	250	A
Avalanche current		I_{AS}^5	15	A
Avalanche energy,		E_{AS}^5	120	mJ
Maximum power dissipation	$T_C=25^\circ\text{C}$	P_D	88	W
	$T_C=100^\circ\text{C}$		44	W
Junction & storage temperature range		T_J, T_{STG}	-55-175	$^\circ\text{C}$

5. Thermal characteristics

Parameter	Symbol	Rating		Unit
		To-252	To-220	
Thermal resistance, Junction-ambient	$R_{\theta JA}$	100	62.5	$^\circ\text{C/W}$
Thermal resistance, Junction-case	$R_{\theta JC}$	1.1	1.7	$^\circ\text{C/W}$

6. Electrical characteristics

(T_A=25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _{DS} =250μA	60	-	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =48V, V _{GS} =0V	-	-	1	μA
		T _J =125°C	-	-	20	
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	3.0	4.0	V
Gate leakage current	I _{GSS}	V _{GS} =±25V, V _{DS} =0V	-	-	±100	nA
Drain-source on-resistance	R _{DS(on)} ¹	V _{GS} =10V, I _D =30A	-	10.5	12.5	mΩ
Gate resistance	R _g	V _{DS} =0V, V _{GS} =0V, f=1MHz	-	1.0	-	Ω
Diode forward voltage	V _{SD} ¹	I _{SD} =30A, V _{GS} =0V	-	0.8	1.3	V
Diode continuous forward current	I _S ³		-	-	50	A
Reverse recovery time	t _{rr}	I _F =30A , dI _{SD} /dt=100A/μs	-	32	-	nS
Reverse recovery charge	Q _{rr}		-	60	-	nC
Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	2060	-	pF
Output capacitance	C _{oss}		-	755	-	
Reverse transfer capacitance	C _{rss}		-	375	-	
Turn-on delay time	t _{d(on)}	V _{DD} =30V, I _D =30A, R _G =5Ω, V _{GS} =10V	-	14	-	nS
Rise time	t _r		-	13	-	
Turn-off delay time	t _{d(off)}		-	20	-	
Fall time	t _f		-	7.5	-	
Total gate charge	Q _g	V _{DS} =48V, V _{GS} =10V I _{DS} =30A	-	50	-	nC
Gate-source charge	Q _{gs}		-	12	--	
Gate-drain charge	Q _{gd}		-	17	--	

Note:1: Pulse test; pulse width ≤ 300μs duty cycle ≤ 2%.

2: Guaranteed by design, not subject to production testing.

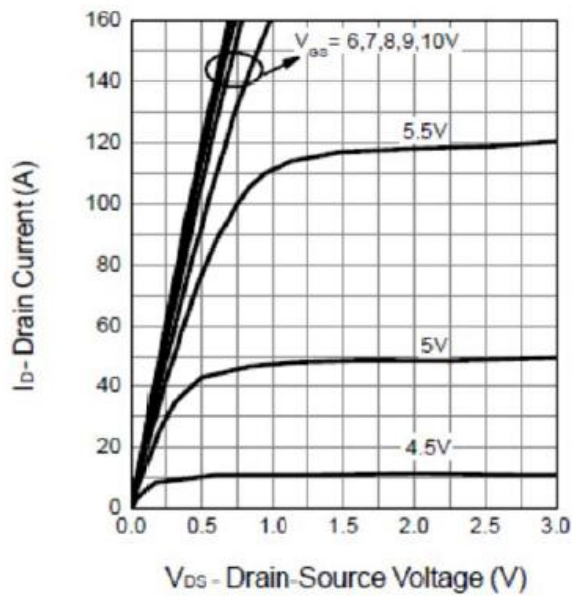
3: Package limitation current is 50A. Calculated continuous current based on maximum allowable junction temperature.

4: Repetitive rating, pulse width limited by max junction temperature.

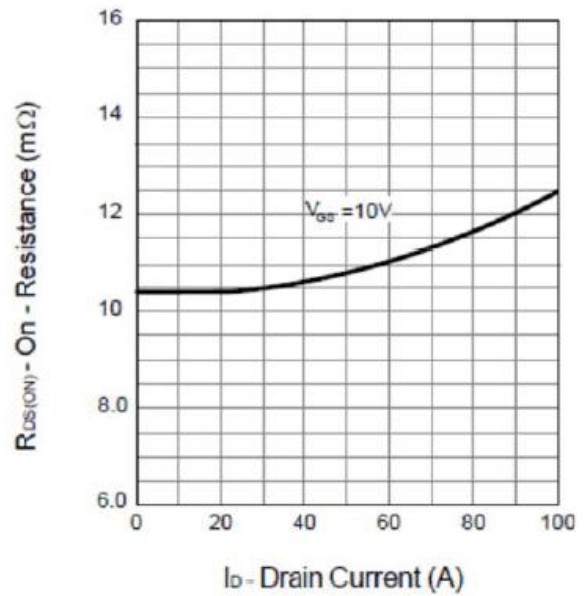
5: Starting T_J=25°C, L=0.5mH, I_{AS}=31A.

7. Test circuits and waveforms

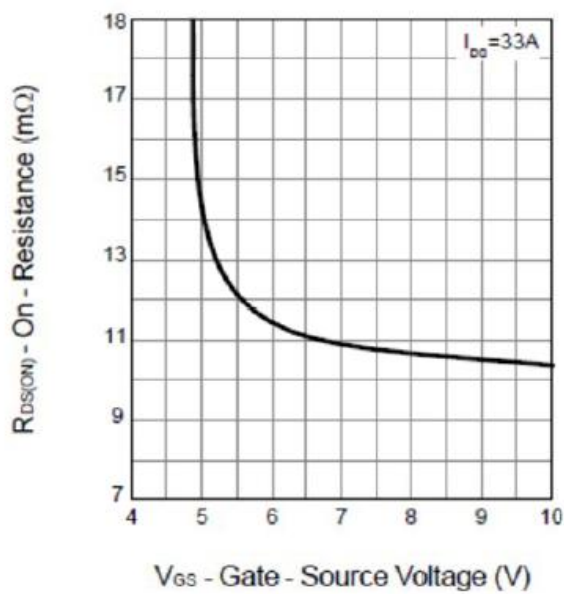
Output Characteristics



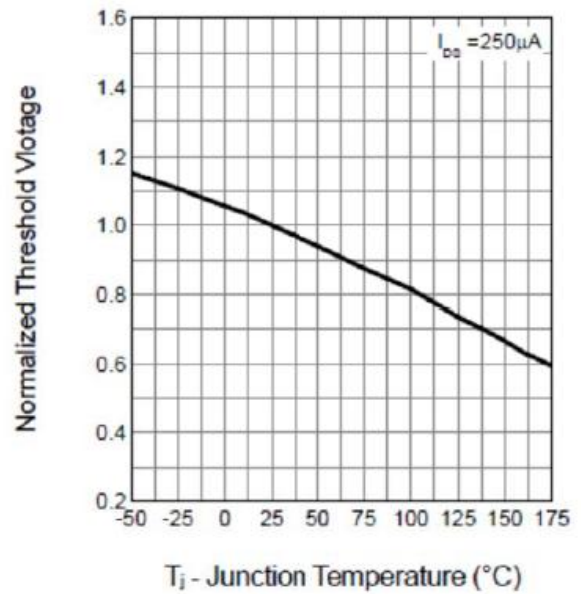
Drain-Source On Resistance



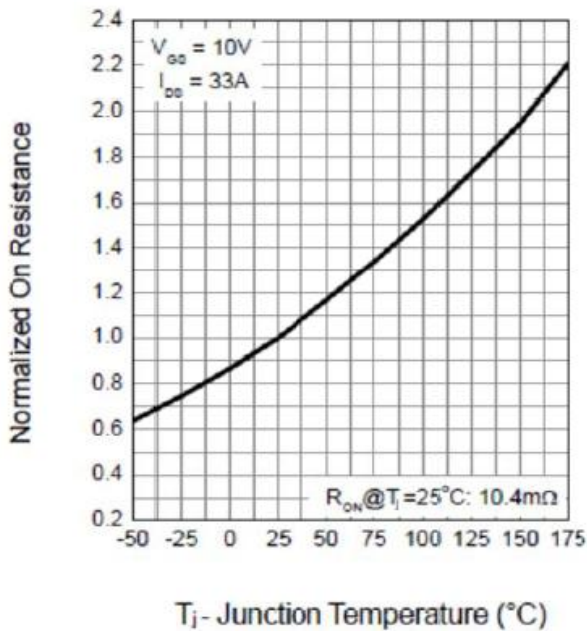
Drain-Source On Resistance



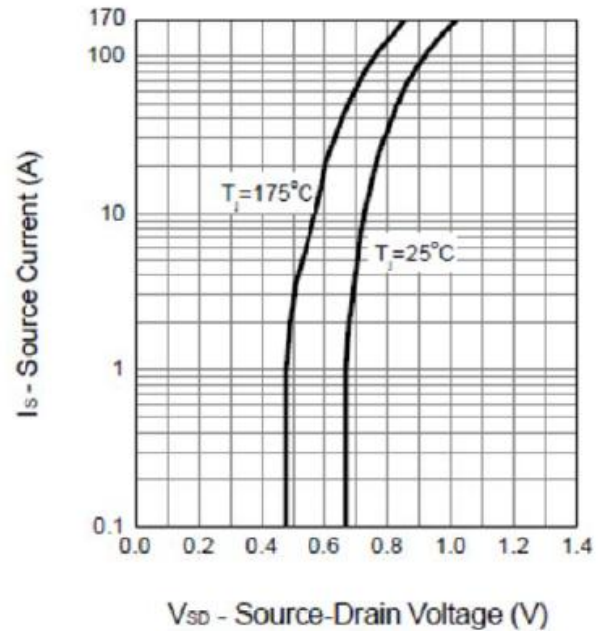
Gate Threshold Voltage



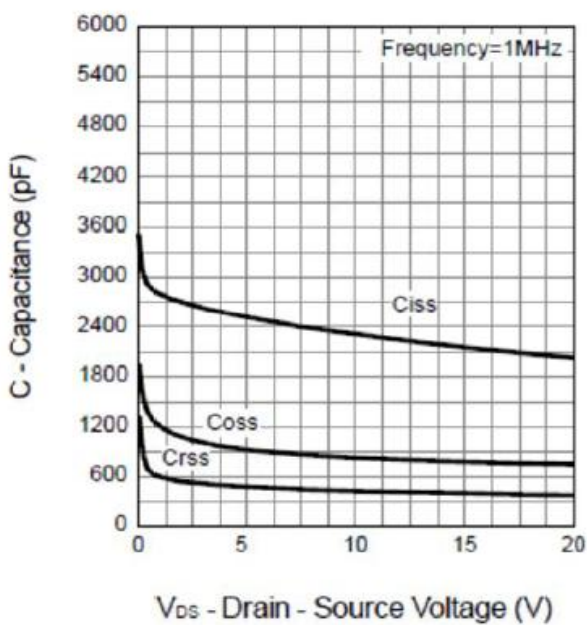
Drain-Source On Resistance



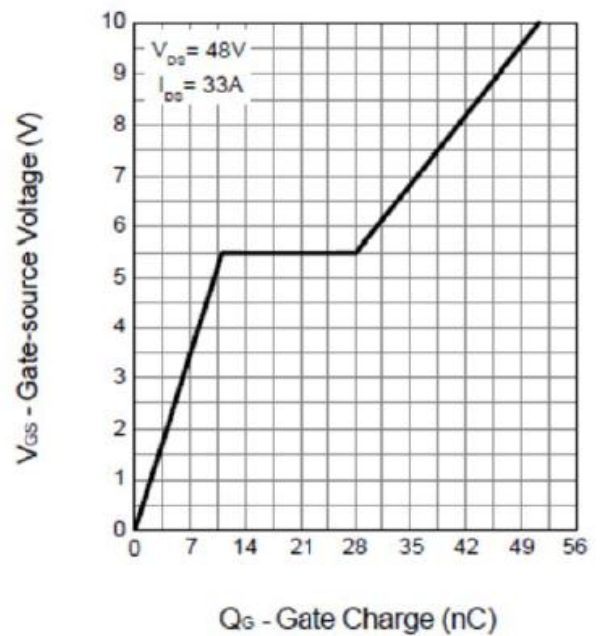
Source-Drain Diode Forward



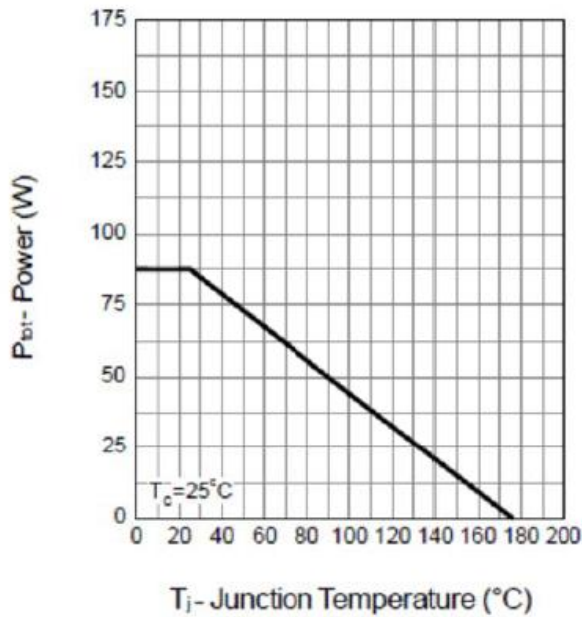
Capacitance



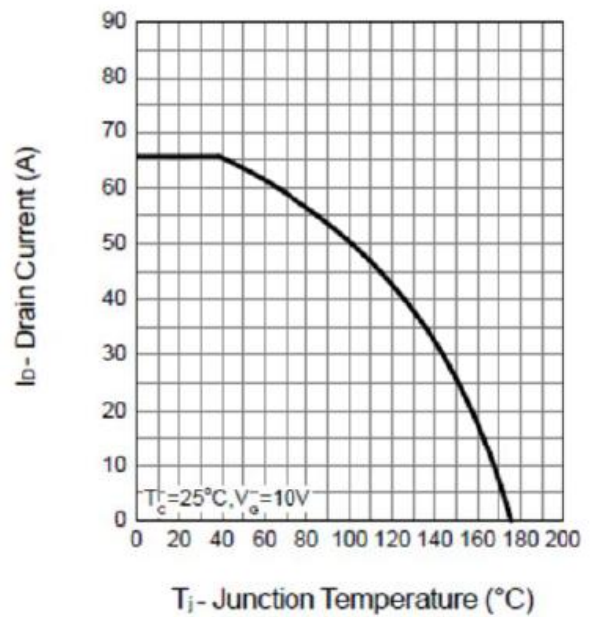
Gate Charge



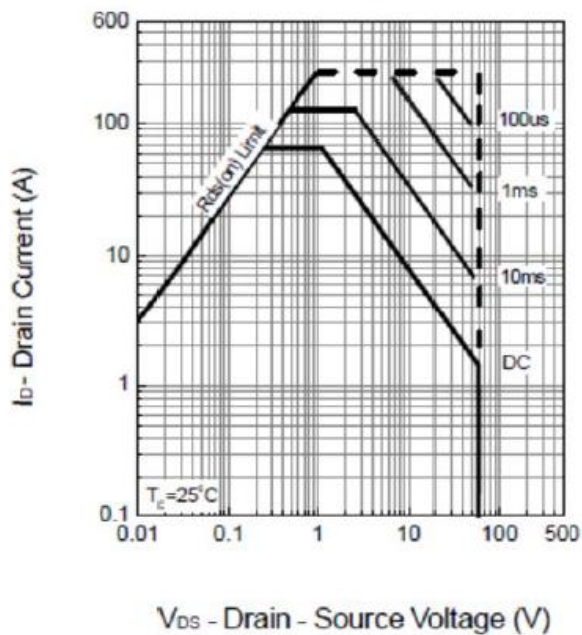
Power Dissipation



Drain Current



Safe Operation Area



Thermal Transient Impedance

